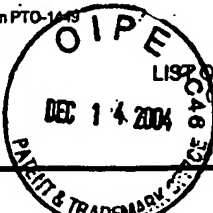


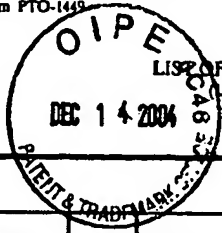
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M22-1951		SERIAL NO. 10/086,942	
 <p>LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)</p>				APPLICANT Cem Basceri			
				FILING DATE March 1, 2002 (RCE filed herewith)		GROUP 2813	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
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	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
CC	AM	EP 0 835 950 A1	04/98	EPO			
CC	AN	0 474 140 A1	03/92	EPO			
	AO						
	AP						
	AQ						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
	AT						
EXAMINER		DATE CONSIDERED					
Chandra Chaudhari		2-05					
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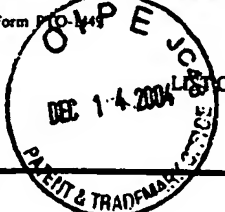
Sheet 1 of 3

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1951		SERIAL NO. 10086,942		
				LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				
				APPLICANT Cem Basceri FILING DATE March 1, 2002 GROUP 2813				
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
CC	AA	4,261,698	04/81	Carr et al.				
	AB	4,691,662	09/87	Roppel et al.				
	AC	5,261,961	11/93	Takasu et al.				
	AD	5,270,241	12/93	Dennison et al.				
	AE	5,312,783	05/94	Takasaki et al.				
	AF	5,392,189	02/95	Fazan et al.				
	AG	5,395,771	03/95	Nakato				
	AH	5,468,687	11/95	Carl et al.				
	AI	5,525,156	06/96	Manada et al.				
	AJ	5,614,018	03/97	Azuma et al.				
	AK	5,656,329	08/97	Hampden-Smith				
↓	AL	5,663,089	09/97	Tomozawa et al.				
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
CC	AM	EP 0 030 798	06/81	EPO - Hughes			N/A	
CC	AN	GB 2 194 555 A	03/88	UK - Nippon			N/A	
CC	AO	EP 0 306 069 A2	03/89	EPO - Phillips			N/A	
	AP							
	AQ							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
CC	AR	Aoyama et al., "Leakage Current Mechanism of Amorphous and Polycrystalline Ta ₂ O ₅ Films Grown by chemical Vapor Deposition," 1995, pages 977-983.						
CC	AS	Stemmer et al., "Accommodation of nonstoichiometry in (100) fiber-textured ... thin films grown by chemical vapor deposition," ©1999 American Institute of Physics, pages 2432-2434.						
CC	AT	Streiffner et al., "Ferroelectricity in thin films: The dielectric response of fiber-textured ... thin films grown by chemical vapor deposition," ©1999 American Institute of Physics, pages 4563-4575.						
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Form PTO-10-1		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1951		SERIAL NO. 10/086,942	
				APPLICANT Cem Basceri		FILING DATE March 1, 2002	
				GROUP 2813			
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
CC	AA	5,702,562	12/97	Wakahara			
	AB	5,719,417	02/98	Roeder et al.			
	AC	5,723,361	03/98	Azuma et al.			
	AD	5,736,759	04/98	Hausaalter			
	AE	5,976,990	11/99	Mercaldi et al.			
	AF	5,989,927	11/99	Yamamoto			
	AG	6,101,085	08/00	Kawahara et al.			
	AH	6,215,650	04/01	Gaede et al.			
	AI	6,258,654	07/01	Gosho			
	AJ	6,287,933	09/01	Coursey			
	AK	6,325,017 B1	12/01	DeBoer et al.			
↓	AL	6,335,049 B1	01/02	Basceri			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
CC	AM	JP 04-24922	01/92	Japan - Mitsubishi			X
CC	AN	JP 04-115533	04/92	Japan - Oki Elec.			X
CC	AO	JP 04-180566	06/92	Japan - Mitsubishi			ABS
CC	AP	JP 08-060347	03/96	Japan - Fujitsu			X
CC	AQ	EP 0 810 646 A1	12/97	EPO - Oki Electric			N/A
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
	AS						
	AT						
EXAMINER Chandra Chaudhari				DATE CONSIDERED 2-05			
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Form PTO-4499		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1931		SERIAL NO. 10/086,942		
 LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Cem Basceri				
				FILING DATE March 1, 2002		GROUP 2813		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
CC	AA	6,566,147 B2	05/03	Basceri et al.				
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
CC	AM	EP 0 892 426 A2	01/99	EPO - Ramtron			N/A	
CC	AN	WO 01/16395	03/01	WIPO - Micron			N/A	
	AO							
	AP							
	AQ							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
	AT							
EXAMINER				DATE CONSIDERED				
Chandra Chaudhari				2-05				
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